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# **Dual 30-V N-Channel NexFET™ Power MOSFETs**

### **FEATURES**

- Common Source Connection
- Ultra Low Drain to Drain On-Resistance
- Space Saving SON 3.3 x 3.3mm Plastic Package
- Optimized for 5V Gate Drive
- Low Thermal Resistance
- Avalanche Rated
- Pb Free Terminal Plating
- RoHS Compliant
- Halogen Free

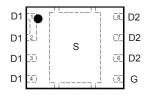
### **APPLICATIONS**

 Adaptor/USB Input Protection for Notebook PCs and Tablets

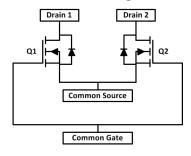
### DESCRIPTION

The CSD87312Q3E is a 30V common-source, dual N-channel device designed for adaptor/USB input protection. This SON 3.3 x 3.3mm device has low drain to drain on-resistance that minimizes losses and offers low component count for space constrained multi-cell battery charging applications.

### **Top View**



### **Circuit Image**



#### PRODUCT SUMMARY

T <sub>A</sub> = 25°	С	TYPICAL VA	UNIT	
$V_{DS}$	Drain to Source Voltage	30	V	
$Q_g$	Gate Charge Total (4.5V)	6.3		nC
$Q_{gd}$	Gate Charge Gate to Drain	0.7	nC	
0	Drain to Drain On Resistance	$V_{GS} = 4.5V$	31	mΩ
R <sub>DD(on)</sub>	(Q1+Q2)	V <sub>GS</sub> = 8V 27		mΩ
V <sub>GS(th)</sub>	Threshold Voltage	1.0	٧	

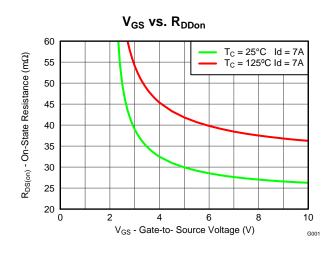
### ORDERING INFORMATION

Device	evice Package Media		Qty	Ship	
CSD87312Q3E	SON 3.3 x 3.3mm Plastic Package	13-Inch Reel	2500	Tape and Reel	

#### **ABSOLUTE MAXIMUM RATINGS**

$T_A = 2$	5°C	VALUE	UNIT
$V_{DS}$	Drain to Source Voltage	30	V
$V_{GS}$	Gate to Source Voltage	+10/-8	V
I <sub>D</sub>	Continuous Drain Current, T <sub>C</sub> = 25°C <sup>(1)</sup>	27	Α
$I_{DM}$	Pulsed Drain Current (2)	45	Α
$P_D$	Power Dissipation	2.5	W
$T_J$ , $T_{STG}$	Operating Junction and Storage Temperature Range	-55 to 150	°C
E <sub>AS</sub>	Avalanche Energy, single pulse $I_D$ = 24A, L = 0.1mH, $R_G$ = 25 $\Omega$	29	mJ

- (1) Typical R = $63^{\circ}$ C/W on 1in<sup>2</sup> (2 oz.) on 0.060" thick FR4PCB
- (2) Pulse duration ≤300µs, duty cycle ≤2%



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### **ELECTRICAL CHARACTERISTICS**

(T<sub>A</sub> = 25°C unless otherwise stated)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Static CI	naracteristics					
BV <sub>DSS</sub>	Drain to Source Voltage	$V_{GS} = 0V, I_D = 250\mu A$	30			V
I <sub>DSS</sub>	Drain to Source Leakage Current	$V_{GS} = 0V, V_{DS} = 24V$			1	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{DS} = 0V, V_{GS} = +10/-8V$			100	nA
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu A$	0.8	1.0	1.3	V
D	Drain to Drain On Resistance (Q1 +	$V_{GS} = 4.5V, I_D = 7A$		31	38	mΩ
R <sub>DD(on)</sub>	Q2)	$V_{GS} = 8V$ , $I_D = 7A$		27	33	mΩ
9 <sub>fs</sub>	Transconductance	$V_{DS} = 15V, I_{D} = 7A$		39		S
Dynamic	: Characteristics <sup>(1)</sup>					
C <sub>iss</sub>	Input Capacitance			960	1250	pF
C <sub>oss</sub>	Output Capacitance	$V_{GS} = 0V, V_{DS} = 15V, f = 1MHz$		190	247	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			12	16	pF
$R_G$	Series Gate Resistance			5	10	Ω
Qg	Gate Charge Total (4.5V)			6.3	8.2	nC
$Q_{gd}$	Gate Charge Gate to Drain	\/ 45\/   70		0.7		nC
Q <sub>gs</sub>	Gate Charge Gate to Source	$V_{DS} = 15V, I_D = 7A$		1.9		nC
Q <sub>g(th)</sub>	Gate Charge at Vth			1.0		nC
Q <sub>oss</sub>	Output Charge	V <sub>DS</sub> = 15V, V <sub>GS</sub> = 0V		4.0		nC
t <sub>d(on)</sub>	Turn On Delay Time			7.8		ns
t <sub>r</sub>	Rise Time	V 45V V 45V L 7A B 20		16		ns
t <sub>d(off)</sub>	Turn Off Delay Time	$V_{DS} = 15V, V_{GS} = 4.5V, I_{DS} = 7A, R_G = 2\Omega$		17		ns
t <sub>f</sub>	Fall Time			2.9		ns
Diode C	haracteristics <sup>(1)</sup>				,	
V <sub>SD</sub>	Diode Forward Voltage	I <sub>SD</sub> = 7A, V <sub>GS</sub> = 0V		0.8	1	V
Q <sub>rr</sub>	Reverse Recovery Charge	V 45V L 7A 4:/4t 200A/		5.3		nC
t <sub>rr</sub>	Reverse Recovery Time	$V_{DS}$ = 15V, $I_F$ = 7A, di/dt = 300A/ $\mu$ s		12.2		ns
			•			

<sup>(1)</sup> All Dynamic and Diode Characteristics were measured with respect to one of the two drains, with the other left floating.

### THERMAL CHARACTERISTICS

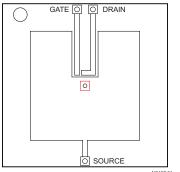
(T<sub>A</sub> = 25°C unless otherwise stated)

	PARAMETER	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Thermal Resistance Junction to Case <sup>(1)</sup>			4.2	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient <sup>(1)(2)</sup>			63	°C/W

 <sup>(1)</sup> R<sub>θ,JC</sub> is determined with the device mounted on a 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu pad on a 1.5-inch x 1.5-inch (3.81-cm x 3.81-cm), 0.06-inch (1.52-mm) thick FR4 PCB. R<sub>θ,JC</sub> is specified by design, whereas R<sub>θ,JA</sub> is determined by the user's board design.
(2) Device mounted on FR4 material with 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu.

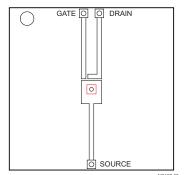
RUMENTS





Instruments

Max  $R_{\theta JA} = 63^{\circ}C/W$ when mounted on 1 inch2 (6.45 cm2) of 2oz. (0.071-mm thick) Cu.



Max  $R_{\theta JA} = 165^{\circ}C/W$ when mounted on a minimum pad area of 2-oz. (0.071-mm thick) Cu.

### TYPICAL MOSFET CHARACTERISTICS

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 

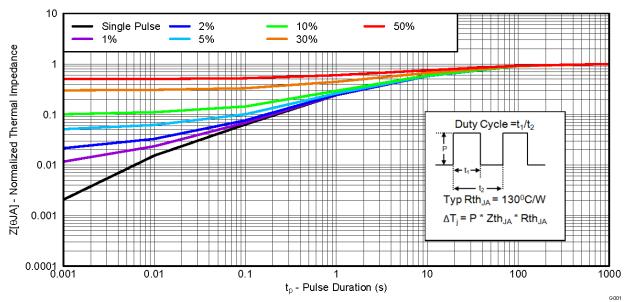


Figure 1. Transient Thermal Impedance

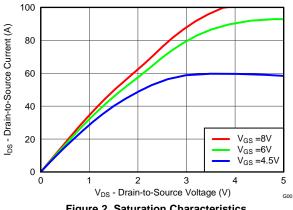


Figure 2. Saturation Characteristics

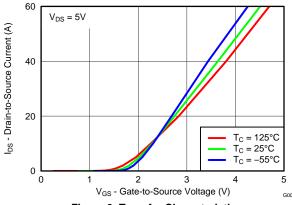


Figure 3. Transfer Characteristics

# TEXAS INSTRUMENTS

### TYPICAL MOSFET CHARACTERISTICS (continued)

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 

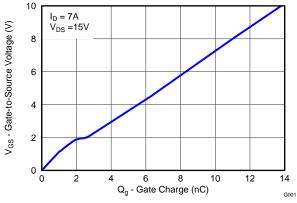


Figure 4. Gate Charge

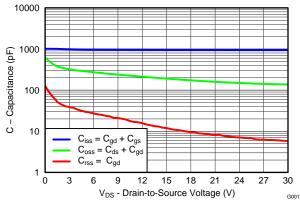


Figure 5. Capacitance

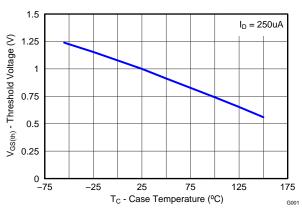


Figure 6. Threshold Voltage vs. Temperature

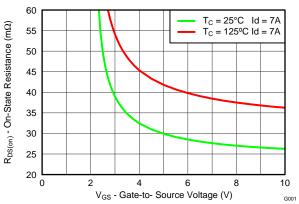


Figure 7. On-State Resistance vs. Gate-to-Source Voltage

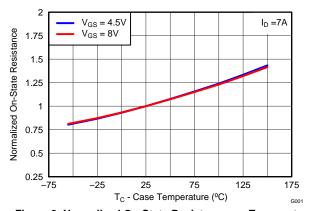


Figure 8. Normalized On-State Resistance vs. Temperature

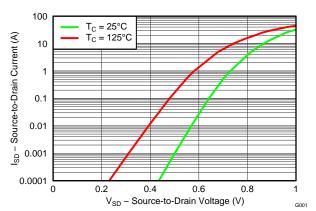


Figure 9. Typical Diode Forward Voltage



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# **TYPICAL MOSFET CHARACTERISTICS (continued)**

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 

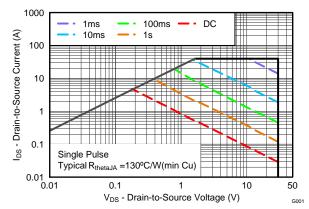


Figure 10. Maximum Safe Operating Area

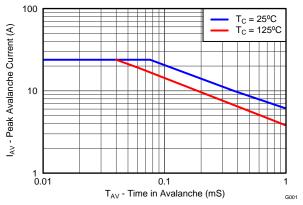


Figure 11. Single Pulse Unclamped Inductive Switching

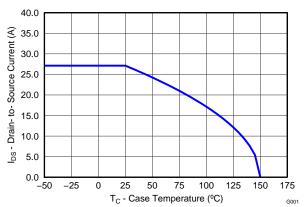
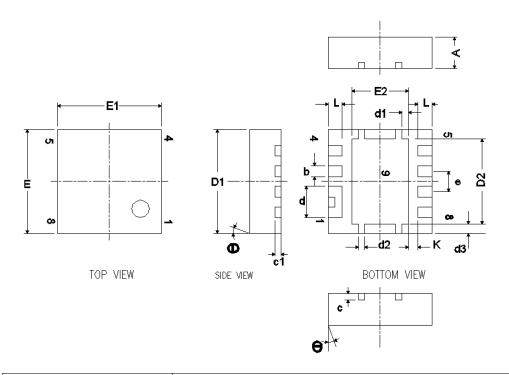


Figure 12. Maximum Drain Current vs. Temperature



# **MECHANICAL DATA**

# **Q3E Package Dimensions**



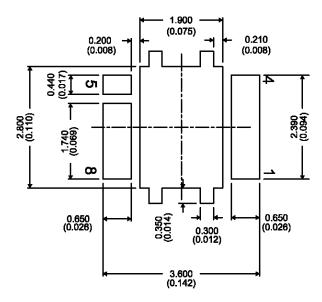
DIM	MILLIMETERS					
DIM	MIN	MAX				
Α	0.850	1.050				
b	0.280	0.400				
С	0.150	0.250				
c1	0.150	0.250				
d	0.940	1.040				
d1	0.160	0.260				
d2	0.150	0.250				
d3	0.250	0.350				
D1	3.200	3.400				
D2	2.650	2.750				
E	3.200	3.400				
E1	3.200	3.400				
E2	1.750	1.850				
е	0.68	50 TYP				
L	0.400	0.500				
θ	0°	-				
K	0.300 Typ					

### Notes:

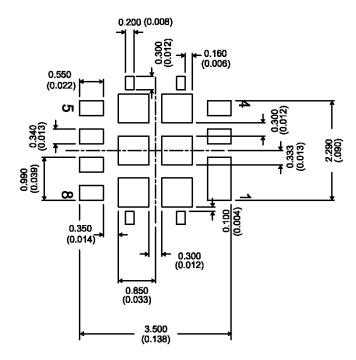
- 1. Pin 1-4: Drain 1
- 2. Pin 5: Gate
- 3. Pin 6-8: Drain 2
- 4. Pin 9: Source

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### **Recommended PCB Pattern**



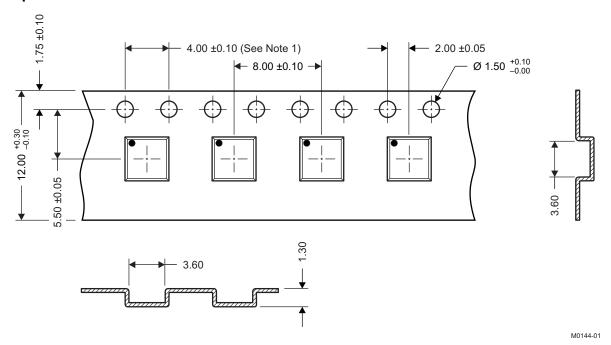
# **Recommended Stencil Opening**



For recommended circuit layout for PCB designs, see application note SLPA005 – Reducing Ringing Through PCB Layout Techniques.



# **Q3E Tape and Reel Information**



### Notes:

- 1. 10 sprocket hole pitch cumulative tolerance ±0.2
- 2. Camber not to exceed 1mm IN 100mm, noncumulative over 250mm
- 3. Material:black static dissipative polystyrene
- 4. All dimensions are in mm (unless otherwise specified)
- 5. Thickness: 0.30 ±0.05mm
- 6. MSL1 260°C (IR and Convection) PbF Reflow Compatible



# PACKAGE OPTION ADDENDUM

6-Feb-2018

### PACKAGING INFORMATION

Orderable Device	Status	Package Type	U	Pins	U	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
CSD87312Q3E	ACTIVE	VSON-CLIP	DPB	8	2500	Pb-Free (RoHS Exempt)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 150	87312E	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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# PACKAGE MATERIALS INFORMATION

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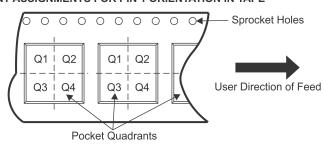
# TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



### \*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD87312Q3E	VSON- CLIP	DPB	8	2500	330.0	12.4	3.6	3.6	1.2	8.0	12.0	Q2

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### \*All dimensions are nominal

Device	Device Package Type		Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
CSD87312Q3E	VSON-CLIP	DPB	8	2500	367.0	367.0	35.0	

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